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	Milanfar, P.; Karl, W.C.; Wil	Itional approach to tomographi <i>Ilsky, A.S.;</i> nsactions on , Volume: 5 Issue: 3	
	[Abstract] [PDF Full-Text ((1976 KB)] IEEE JNL	

4 Wigner-Radon representations for 3-D seismic data analysis Steeghs, P.;

Time-Frequency and Time-Scale Analysis, 1998. Proceedings of the IEEE-SP International Symposium on , 6-9 Oct. 1998

Page(s): 433 -436

[Abstract] [PDF Full-Text (556 KB)] **IEEE CNF**

5 Invariant image analysis based on Radon transform and SVD

AI-Shaykh, O.K.; Doherty, J.F.;

Circuits and Systems II: Analog and Digital Signal Processing, IEEE Transaction

Volume: 43 Issue: 2, Feb. 1996

Page(s): 123 -133

[Abstract] [PDF Full-Text (1052 KB)] IEEE JNL

6 Pattern recognition using invariants defined from higher order spectimage inputs

Chandran, V.; Carswell, B.; Boashash, B.; Elgar, S.;

Image Processing, IEEE Transactions on , Volume: 6 Issue: 5 , May 1997

Page(s): 703 -712

[Abstract] [PDF Full-Text (216 KB)] IEEE JNL

7 Wavelet-based multiresolution local tomography

Rashid-Farrokhi, F.; Liu, K.J.R.; Berenstein, C.A.; Walnut, D.;

Image Processing, IEEE Transactions on , Volume: 6 Issue: 10 , Oct. 1997

Page(s): 1412 -1430

[Abstract] [PDF Full-Text (1260 KB)] IEEE JNL

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